MSKSEMI 美森科













ESD

TV

TSS

MOV

GDT

PLED

AONR36368-MS

Product specification





Description

The AONR36368-MSuses advanced trench technology to provide excellent RDS(ON), low gate charge and operation with gate voltages as low as 4.5V.

This device is suitable for use as a Battery protection or in other Switching application.

Features

V_{DS} = 30V I_D =60 A

 $R_{DS(ON)}$ < $8m\Omega$ @ V_{GS} =-10V

Application

- Battery protection
- Load switch
- Uninterruptible power supply

Reference News

PACKAGE OUTLINE	N-Channel MOSFET	Marking
DFN3X3-8L	G S	60N03 • XXXX



Absolute Maximum Ratings (TC=25℃ unless otherwise specified)

Symbol	Parameter	Rating	Units
VDS	Drain-Source Voltage	30	V
Vgs	Gate-Source Voltage	±20	V
In@Tc=25°C	Continuous Drain Current, V _{GS} @ 10V¹	60	Α
In@Tc=100°C	Continuous Drain Current, V _{GS} @ 10V¹	20	Α
Id@Ta=25°C	Continuous Drain Current, V _{GS} @ 10V¹	15	Α
Id@Ta=70°C	Continuous Drain Current, V _{GS} @ 10V¹	12	А
Ірм	Pulsed Drain Current ²	140	А
EAS	Single Pulse Avalanche Energy ³	115.2	mJ
las	Avalanche Current	48	Α
Pp@Tc=25°C	Total Power Dissipation ⁴	59	W
Pd@Ta=25°C	Total Power Dissipation ⁴	2	W
Тѕтс	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C
Reja	Thermal Resistance Junction-ambient ¹	62	°C/W
Reuc	Thermal Resistance Junction-Case ¹	2.1	°C/W



Electrical Characteristics (TJ=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain- Source Breakdown Voltage	Vgs=0V , ID=250uA	30			V
∆BVɒss/∆Tյ	BVDSS Temperature Coefficient	Reference to 25 °C , I _D =1mA		0.027		V/°C
		V _G s=10V , I _D =20A		6	8	
Rds(on)	Static Drain-Source On- Resistance ²	V _G s=4.5V , I _D =10A		7.5	10	mΩ
V _{GS(th)}	Gate Threshold Voltage		1.2		2.5	V
$\triangle V$ GS(th)	VGS(th) Temperature Coefficier			-5.8		Mv/℃
		V _{DS} =24V , V _{GS} =0V , T _J =250			1	
loss	Drain-Source Leakage Current	V _{DS} =24V , V _{GS} =0V , T _J =55 °C			5	uA
lgss	Gate- Source Leakage Curren	t V _{GS} = ±20V , V _{DS} =0V			± 100	nA
gfs	Forward Transconductance	V _{DS} =5V , I _D =30A		43		S
Rg	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		1.7		Ω
Qg	Total Gate Charge (4.5V)			20		
Qgs	Gate- Source Charge	V _{DS} =15V , V _{GS} =4.5V		7.6		0
Qgd	Gate- Drain Charge	, I□=15A		7.2		nC
Td(on)	Turn- On Delay Time			7.8		
Tr	Rise Time	VDD=15V , VGS=10V		15		
T _{d(off)}	Turn- Off Delay Time	, R _G =3.3 Ω		37.3		ns
Tf	Fall Time	ID=15A		10.6		
Ciss	Input Capacitance			2295		
Coss	Output Capacitance	V _{DS} =15V , V _{GS} =0V ,		267		. –
Crss	Reverse Transfer Capacitano	f=1MHz		210		pF
ls	Continuous Source Current ^{1, 6}	V _G =V _D =0V , Force			40	Α
Ism	Pulsed Source Current ^{2,6}	Current			140	Α
Vsp	Diode Forward Voltage ²	V _G s=0V , I _S =1A , T _J =25 °C			1	V

Diode Characteristics

Note:

- 1. The data tested by surface mounted on a 1 inch2 FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width \leqq 300us , duty cycle \leqq 2%
- 3 .The EAS data shows Max. rating . The test condition is V_{DD} =25V, V_{GS} =10V,L=0.1mH,Ias=34A
- 4.The power dissipation is limited by 150 $\!\!\!\!\!^{\,\mathrm{C}}$ junction temperature
- 5 .The data is theoretically the same as l_D and l_{DM} , in real applications , should be limited by total power dissipation.



Typical Characteristics

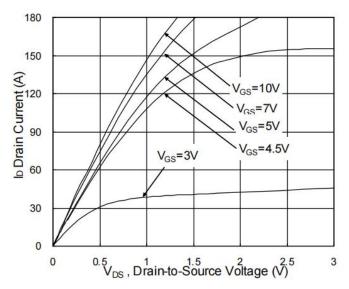


Fig.1 Typical Output Characteristics

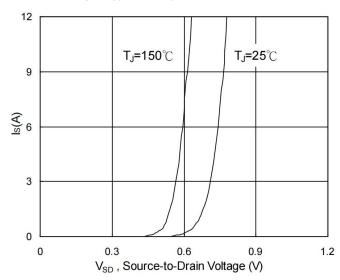


Fig.3 Forward Characteristics of Reverse

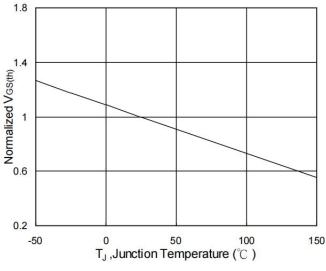


Fig.5 Normalized Vgs(th) vs. TJ

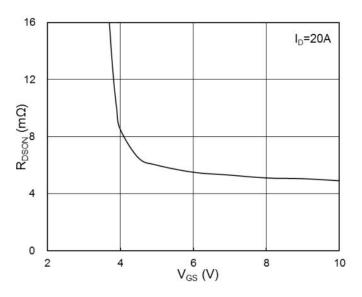


Fig.2 On-Resistance vs. G-S Voltage

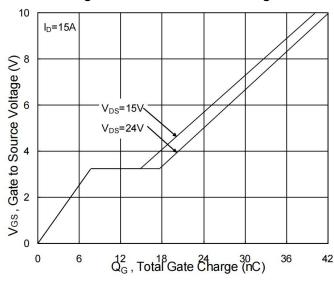


Fig.4 Gate-Charge Characteristics

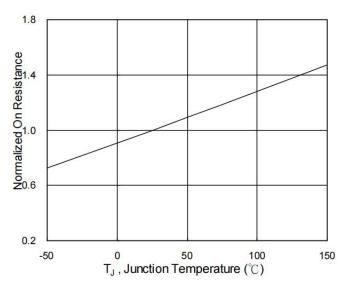
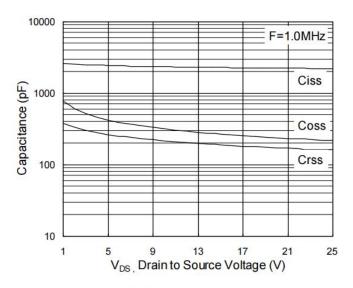


Fig.6 Normalized RDSON vs. TJ



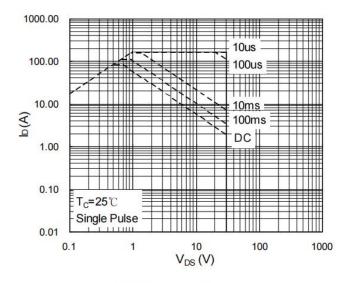


Fig.7 Capacitance

Fig.8 Safe Operating Area

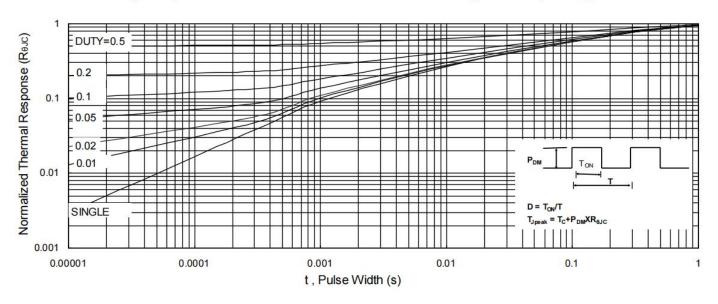


Fig.9 Normalized Maximum Transient Thermal Impedance

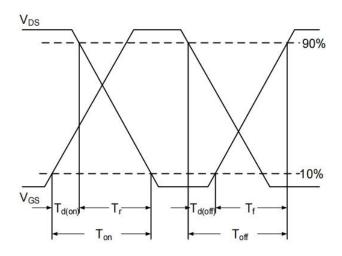


Fig.10 Switching Time Waveform

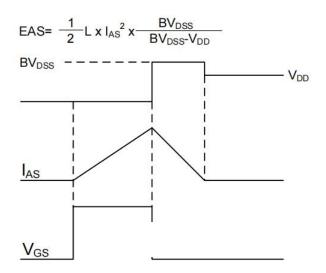
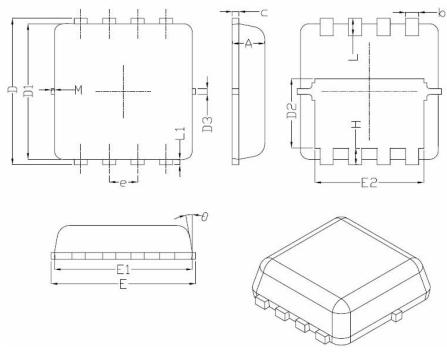


Fig.11 Unclamped Inductive Switching Waveform



DFN3X3-8L Package Information



Symbol	Dimensions In Millimeters		
	Min.	Nom.	Max.
A	0.70	0.75	0.80
b	0.25	0.30	0.35
С	0.10	0.15	0.25
D	3.25	3.35	3.45
D1	3.00	3.10	3.20
D2	1.48	1.58	1.68
D3	-	0.13	-
Е	3.20	3.30	3.40
E1	3.00	3.15	3.20
E2	2.39	2.49	2.59
е	0.65BSC		
Н	0.30	0.39	0.50
L	0.30	0.40	0.50
L1	-	0.13	-
M	*	*	0.15
θ		10°	12 [°]

REEL SPECIFICATION

P/N	PKG	QTY
AONR36368-MS	DFN3X3-8L	5000



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